

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/899,422	HAUPTMANN ET AL.	
Examiner	Art Unit	
Fileen O'Hara	1646	

SEARCHED					
Class	Subclass	Date	Examiner		
530	350	5/11/2005			
536	23.5				
514	2 8				
514	12				
424	85.1				
-					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
530	350	5/11/2005	ЕОН		
514	12				
424	85.1				
STIC SEQ ID NOS: 3 and 4					

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Patentability Conference with Tony Caputa and Elizabeth Kemmerer	5/3/2005	ЕОН
Updated Patent Databases STIC - SEQ ID NOS: 3 and 4	5/11/2005	ЕОН
	·	